



TEST REPORT

According to ANSI/IES LM-80-15
For

Hongli Zhihui Group Co.,Ltd. Guangzhou Branch

Room 316, Building 2, No.1, Xianke Yi Road, Huadong Town, Huadu District, Guangzhou, China

Model: HL-A-3014H416W-S1-08HL-HR3

| | |
|--|-------------------------------------|
| Report Type: 6000 Hours Test Report | Product Type: LED Package |
| Reviewed By: Pote Wang | |
| Report Number: SZ2220725-33706E-EE-6000 | |
| Test Date: 2022-07-29 to 2023-04-05 | |
| Report Date: 2023-05-06 | |
| Approved by: Blake Zhang / EE Engineer | |
| Prepared By: Bay Area Compliance Laboratories Corp. (Shenzhen) 5/F(B-West) -7/F, the 3rd Phase of Wan Li Industrial Building D, Shihua Road, Futian Free Trade Zone Shenzhen, Guangdong, China. Tel: +86-755-33320018 Fax: +86-755-33320008 | |
| Test Facility: Test facility was located at No.12, Pulong East 1 st Road, Tangxia Town, Dongguan, Guangdong, China. | |

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The NVLAP Lab Code is 200707-0

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- *ENERGY STAR® Requirements for the Use of LM-80 Data (This standard was not accredited by NVLAP)

1.3 Testing Equipment

| Device | Manufacture | Model No | Serial No | Calibration date | Calibration due date |
|---|---------------|-------------|------------------|------------------|----------------------|
| 0.5m integrating sphere | EVERFINE | AIS-2 | G185304TA1381172 | 2022-11-18 | 2023-11-17 |
| LED Test Source | EVERFINE | LTS-300 | P185616CD1371113 | 2022-11-18 | 2023-11-17 |
| High Accuracy Array Spectroradiometer | EVERFINE | HAAS-2000 | P600674CM1381123 | 2022-06-07 | 2023-06-06 |
| Standard Light Source | EVERFINE | D062 | 1011093 | 2021-10-15 | 2023-10-14 |
| Multilayer aging machine | BACL | B2-270 | 20015 | 2022-10-19 | 2023-10-18 |
| Program-controlled D.C. Stabilized Voltage Supply | Hanshenpuyuan | HSPY-200-01 | N/A | 2022-10-19 | 2023-10-18 |

1.4 Drive Level

Samples are driven with a constant direct current (DC) during maintenance test, photometric and electrical measurement. The current value was regulated to within $\pm 3\%$ of the specified value of the manufacturer during maintenance test, and was within $\pm 0.5\%$ during photometric and electrical measurement test.

1.5 Ambient Conditions for Maintenance Test

For lumen maintenance test, samples within one data set, were installed on cooling boards in thermal chambers with minimal ambient airflow. The case temperature and ambient temperature was monitored by thermocouples which one was soldered to the coldest DUT's case (TMP_{LED}) location, while the other is mounted at a distance of 5 mm above the TMP location.

During life testing, TMP_{LED} of the coldest LEDs were maintained at a temperature that was greater than or equal to 2°C below the corresponding nominal case temperature. Surrounding air was maintained at a temperature that was greater than or equal to 5°C below the corresponding nominal case temperature. Thermocouples were shielded from direct DUT optical radiation and comply with ASTM E230 Table 1 "Special Limits".

Samples were connected to DC power supply in series circuits with a constant current. The forward current was regulated to within $\pm 3\%$ of the specified value of the manufacturer.

The relative humidity within chamber was kept less than 65% during test.

For photometry measurement, the ambient temperature during test was set to $25^{\circ}\text{C} \pm 2^{\circ}\text{C}$, RH <65%.

1.6 Photometric Measurement Method and Uncertainty

Integrating sphere and spectroradiometer is used to measure luminous flux and chromaticity coordinate $u'v'$. 2π measurement was used and sample was driven by DC power supply. The forward current was regulated to within $\pm 0.5\%$ of the nominal value. The test system was calibrated by halogen reference lamp. The ambient temperature during test was set to $25^{\circ}\text{C} \pm 2^{\circ}\text{C}$, RH <65%. The temperature measurement point was located in the sphere and the temperature was detected by a temperature probe.

The uncertainty of the light output measurements is $U=1.59\%$ ($K=2$), at the 95% confidence level. The uncertainty of the correlated color temperature measurements is $U=21\text{K}$ ($K=2$), at the 95% confidence level.

The uncertainty of the temperature is $U=0.8671^{\circ}\text{C}$ ($K=2$), at the 95% confidence level.

1.7 Statement of Traceability

Bay Area Compliance Laboratories Corp. (Shenzhen) attested that all calibration has been performed using suitable standards traceable to National Primary Standards and International System of Units (SI).



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1.8 Sample Set

Data Set 1: 55°C, 30mA

Part Number: HL-A-3014H416W-S1-08HL-HR3

Number of Units: 25

Case Temperature: >53°C

Ambient Temperature: >50°C

Life Test Drive Current: 30mA

Measurement Current: 30mA

Data Set 2: 85°C, 30mA

Part Number: HL-A-3014H416W-S1-08HL-HR3

Number of Units: 25

Case Temperature: >83°C

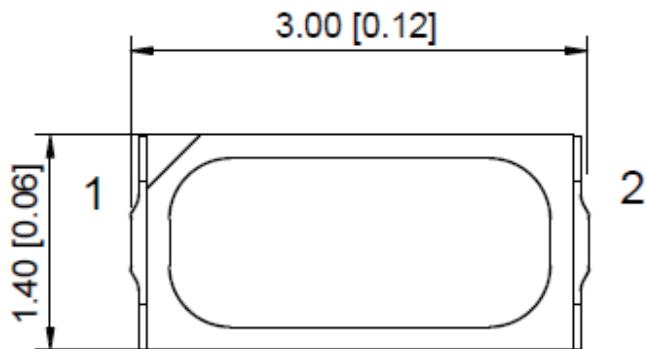
Ambient Temperature: >80°C

Life Test Drive Current: 30mA

Measurement Current: 30mA

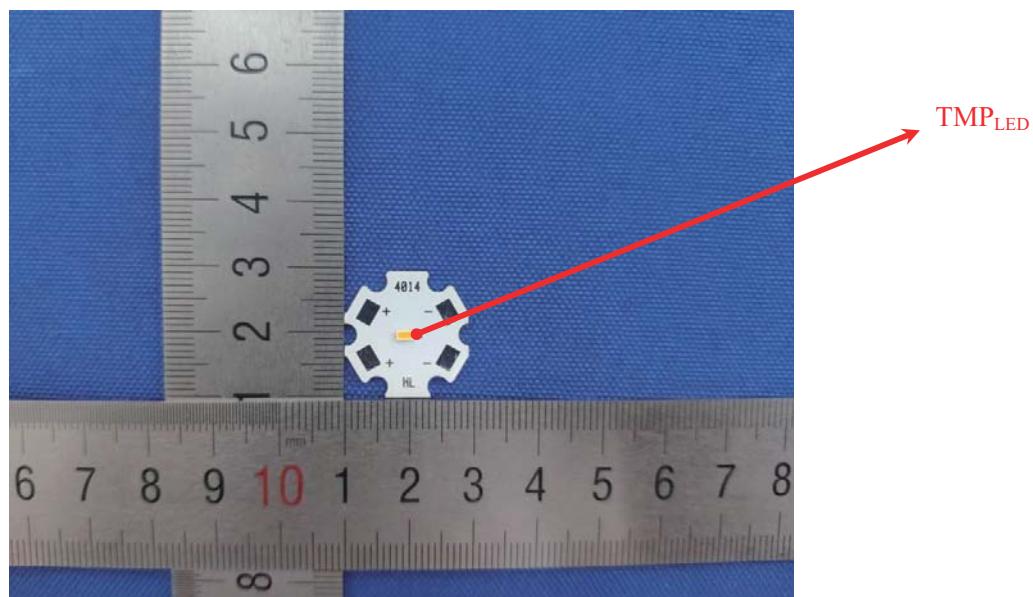
4 - DUT Photo

4.1 Mechanical Dimensions



All dimensions are in millimeter

4.2 DUT Photo





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